Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WATANABE ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,586,349	07-2003	Jeon et al.	438/785
*	В	US-2003/0219972	11-2003	Green et al.	438/623
*	С	US-2003/0137019	07-2003	Maria et al.	257/410
*	D	US-2006/0054980	03-2006	Kim et al.	257/410
*	E	US-2005/0009371	01-2005	Metzner et al.	438/785
	F	US-			
	G	US-			•
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					·
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.